

<b>Notice of References Cited</b>	Application/Control No. 10/716,424	Applicant(s)/Patent Under Reexamination KWON, IL-YOUNG	
	Examiner Joannie A Garcia	Art Unit 2823	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0041884	03-2004	DeBar et al.	347/055
	B	US-2004/0055126	03-2004	DeBar et al.	029/025.35
	C	US-6,770,211	08-2004	DeBar et al.	216/27
	D	US-2003/0203570	10-2003	Song et al.	438/254
	E	US-6,777,759	08-2004	Chau et al.	257/377
	F	US-6,436,612	08-2002	Chang, Ching-Yu	430/316
	G	US-2003/0107041	06-2003	Tanimoto et al.	257/77
	H	US-6,020,215	02-2000	Yagi et al.	438/52
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.